Power MOSFET

30 V, 37 A, Single N-Channel, DPAK/IPAK

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

Applications

- CPU Power Delivery
- DC-DC Converters

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parar	neter		Symbol	Value	Unit
Drain-to-Source Volta	rce Voltage			30	V
Gate-to-Source Volta	ge		V_{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	11.2	Α
Current (R _{θJA}) (Note 1)		T _A = 100°C		7.9	
Power Dissipation (R _{θJA}) (Note 1)		T _A = 25°C	P _D	2.6	W
Continuous Drain Current (R _{0,JA})		T _A = 25°C	I _D	8.2	Α
(Note 2)	Steady	T _A = 100°C		5.8	
Power Dissipation (R _{θJA}) (Note 2)	State	T _A = 25°C	P _D	1.37	W
Continuous Drain Current (R _{B,IC})	1	T _C = 25°C	I _D	37	Α
(Note 1)		T _C = 100°C		26	
Power Dissipation (R _{θJC}) (Note 1)		T _C = 25°C	P _D	27.3	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	152	Α
Current Limited by Pac	kage	T _A = 25°C	I _{DmaxPkg}	60	Α
Operating Junction and	Temperature	T _J , T _{stg}	-55 to 175	°C	
Source Current (Body Diode)			I _S	23	Α
Drain to Source dV/dt		dV/dt	7.0	V/ns	
Single Pulse Drain-to- Energy (T _J = 25°C, V _{DI} L = 0.1 mH, $I_{L(pk)}$ = 22.	$'_{GS} = 10 \text{ V},$	E _{AS}	25.3	mJ	
Lead Temperature for S (1/8" from case for 10 s		urposes	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

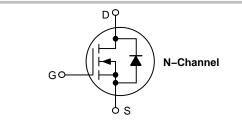
- 1. Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.



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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	9.0 mΩ @ 10 V	37 A
30 V	13 m Ω @ 4.5 V	37 K







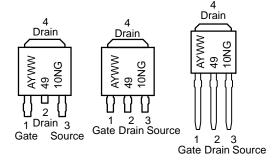


CASE 369AA **DPAK** (Bent Lead) STYLE 2

CASE 369AD **IPAK** (Straight Lead) (Straight Lead

CASE 369D **IPAK** DPAK)

MARKING DIAGRAMS & PIN ASSIGNMENTS



= Assembly Location

= Year WW = Work Week 4910N = Device Code = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 3 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	5.5	°C/W
Junction-to-Tab (Drain)	$R_{\theta JC-TAB}$	4.3	
Junction-to-Ambient - Steady State (Note 3)	$R_{ heta JA}$	58.5	
Junction-to-Ambient - Steady State (Note 4)	$R_{ heta JA}$	109.7	

- 3. Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
- 4. Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Con	dition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D$	= 250 μΑ	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				15		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μΑ
		$V_{DS} = 24 V$	T _J = 125°C			10	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.0	1.6	2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		7.5	9.0	mΩ
			I _D = 15 A		7.5		1
		V _{GS} = 4.5 V	I _D = 30 A		10.6	13	1
			I _D = 15 A		10.6		1
Forward Transconductance	gFS	V _{DS} = 1.5 V,	I _D = 30 A		40		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}				1203		pF
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V, f} = V_{DS} = 1$	•		460		
Reverse Transfer Capacitance	C _{rss}	. 52			12.5		1
Total Gate Charge	Q _{G(TOT)}				6.8		nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 4.5 \text{ V}, \text{ V}$	_{DS} = 15 V,		1.95		1
Gate-to-Source Charge	Q _{GS}	$I_{D} = 30$) A		3.9		1
Gate-to-Drain Charge	Q_{GD}				1.1		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 10 \text{ V, V}$ $I_{D} = 30 \text{ V}$			15.4		nC
SWITCHING CHARACTERISTICS (Note	e 6)						
Turn-On Delay Time	t _{d(on)}				11.6		ns
Rise Time	t _r	V _{GS} = 4.5 V, V	_{DS} = 15 V,		21.8		1
Turn-Off Delay Time	t _{d(off)}	$I_D = 15 \text{ A}, R_C$			16.5		1
Fall Time	t _f		ľ		4.2		1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.

- 6. Switching characteristics are independent of operating junction temperatures.
- 7. Assume terminal length of 110 mils.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
Turn-On Delay Time	t _{d(on)}				7.3		ns
Rise Time	t _r	$V_{GS} = 10 \text{ V}, V_{D}$	_S = 15 V,		19.5		
Turn-Off Delay Time	t _{d(off)}	$I_D = 15 \text{ A}, R_G$	= 3.0 Ω		20.2		
Fall Time	t _f				2.0		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 V$,	$T_J = 25^{\circ}C$		0.91	1.1	V
		$I_{S} = 30 \text{ A}$	T _J = 125°C		0.82		
Reverse Recovery Time	t _{RR}				27		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, dls/dt}$	= 100 A/μs,		14		
Discharge Time	tb	I _S = 30 A	A		13		
Reverse Recovery Time	Q _{RR}				17		nC
PACKAGE PARASITIC VALUES							
Source Inductance (Note 7)	L _S				2.99		nΗ
Drain Inductance, DPAK	L _D	1			0.0164		
Drain Inductance, IPAK (Note 7)	L _D	T _A = 25°	С		1.88		
Gate Inductance (Note 7)	L _G				4.9		
Gate Resistance	R_{G}				1.0	2.0	Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.

- 6. Switching characteristics are independent of operating junction temperatures.
- 7. Assume terminal length of 110 mils.

ORDERING INFORMATION

Order Number	Package	Shipping [†]		
NTD4910NT4G	DPAK (Pb-Free)	2500 / Tape & Reel		
NTD4910N-1G	IPAK (Pb-Free)	75 Units / Rail		
NTD4910N-35G	IPAK Trimmed Lead (Pb-Free)	75 Units / Rail		

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

TYPICAL CHARACTERISTICS

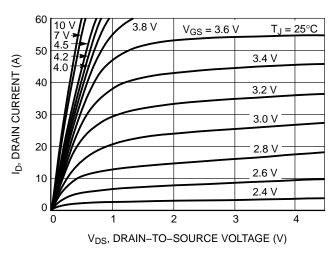


Figure 1. On-Region Characteristics

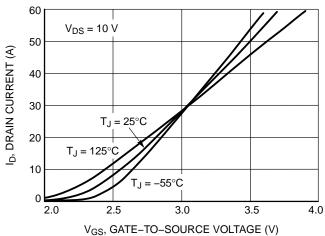


Figure 2. Transfer Characteristics

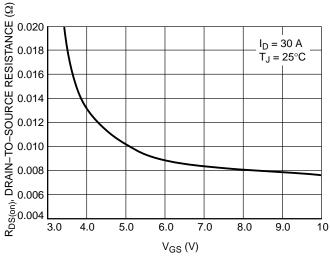


Figure 3. On-Resistance vs. V_{GS}

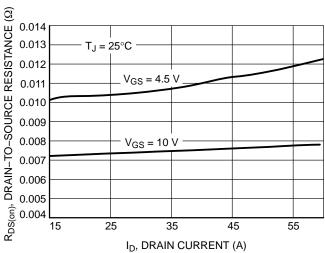


Figure 4. On–Resistance vs. Drain Current and Gate Voltage

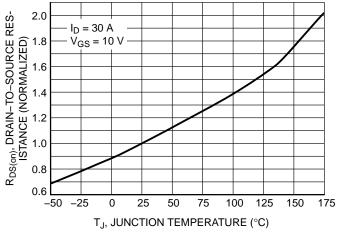


Figure 5. On–Resistance Variation with Temperature

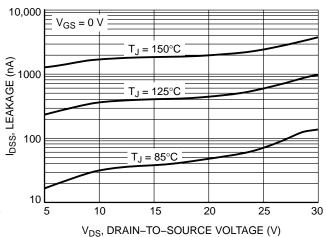


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

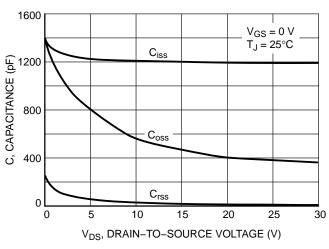


Figure 7. Capacitance Variation

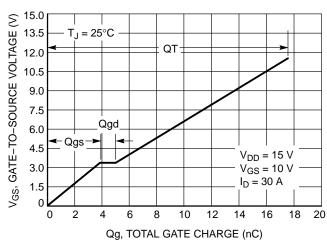


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

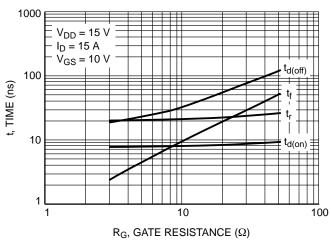


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

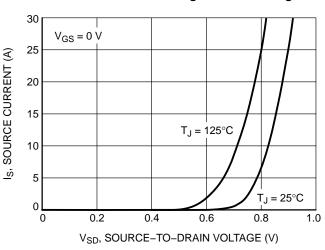


Figure 10. Diode Forward Voltage vs. Current

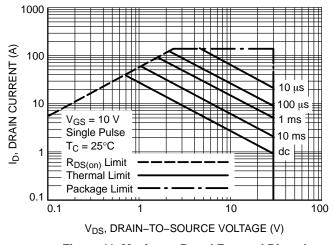


Figure 11. Maximum Rated Forward Biased Safe Operating Area

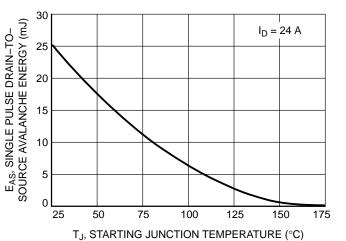


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

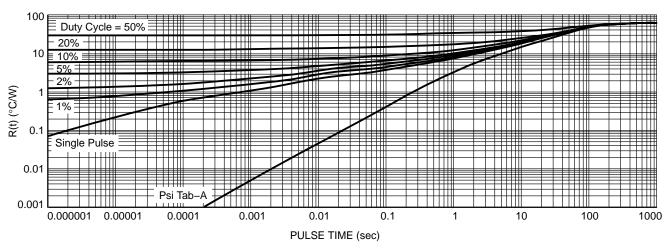


Figure 13. FET Thermal Response

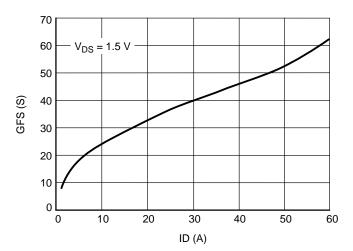


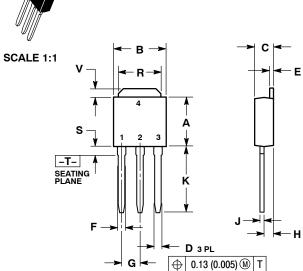
Figure 14. GFS vs. ID

MECHANICAL CASE OUTLINE





DATE 15 DEC 2010



STYLE 2:

PIN 1. GATE

3

STYLE 6: PIN 1. MT1 2. MT2 3. GATE

2. DRAIN

4. DRAIN

MT2

SOURCE

STYLE 1: PIN 1. BASE

3

STYLE 5: PIN 1. GATE

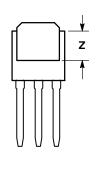
2. ANODE 3. CATHODE

ANODE

2. COLLECTOR

EMITTER

COLLECTOR



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIN	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

MARKING DIAGRAMS

STYLE 3: PIN 1. ANODE

2. CATHODE

4. CATHODE

3 ANODE

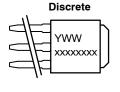
STYLE 7: PIN 1. GATE 2. COLLECTOR

3. EMITTER

COLLECTOR

STYLE 4: PIN 1. CATHODE ANODE
 GATE

4. ANODE

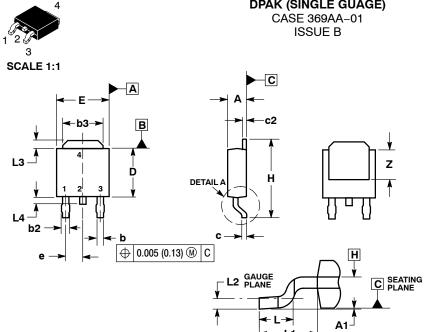




xxxxxxxxx = Device Code Α = Assembly Location IL = Wafer Lot Υ = Year WW = Work Week

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DESCRIPTION:	IPAK (DPAK INSERTION M	IOUNT)	PAGE 1 OF 1	

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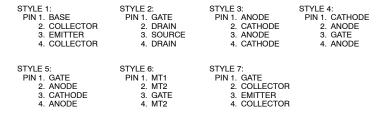


DETAIL A ROTATED 90° CW **DATE 03 JUN 2010**

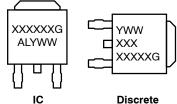
NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74	REF
L2	0.020	BSC	0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	



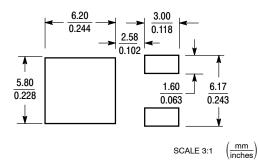
GENERIC MARKING DIAGRAM*



XXXXXX = Device Code Α = Assembly Location L = Wafer Lot ٧ = Year = Work Week WW = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DPAK (SINGLE GAUGE)		PAGE 1 OF 1	

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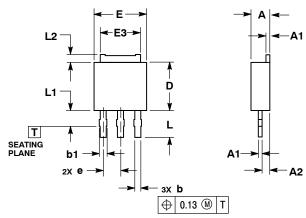


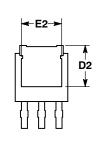
3.5 MM IPAK, STRAIGHT LEAD

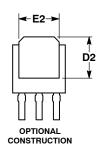
CASE 369AD **ISSUE B**

DATE 18 APR 2013









3. GATE

4.

ANODE

- NOTES:
 1.. DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994. 2.. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30mm FROM TERMINAL TIP.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD GATE OR MOLD FLASH.

	MILLIN	IETERS	
DIM	MIN	MAX	
Α	2.19	2.38	
A1	0.46	0.60	
A2	0.87	1.10	
b	0.69	0.89	
b1	0.77	1.10	
D	5.97	6.22	
D2	4.80		
E	6.35	6.73	
E2	4.57	5.45	
E3	4.45	5.46	
е	2.28 BSC		
L	3.40	3.60	
L1		2.10	
L2	0.89	1.27	

GENERIC MARKING DIAGRAMS*

Discrete



STYL	Ε	1	:	
PIN	1			R/

4.

PIN 1. GATE

STYLE 5:

ASE 2. COLLECTOR 3. **EMITTER**

ANODE
 CATHODE

ANODE

COLLECTOR

STYLE 2: PIN 1. GATE

STYLE 6:

PIN 1. MT1

MT2
 GATE

4. MT2

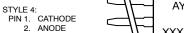
2. DRAIN 3. SOURCE 4. DRAIN

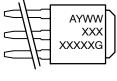
STYLE 3: PIN 1. ANODE 2. CATHODE 3. ANODE

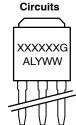
CATHODE 4.

STYLE 7: PIN 1. GATE 2. COLLECTOR 3. EMITTER

COLLECTOR







XXXXXX = Device Code

Α = Assembly Location

L = Wafer Lot Υ = Year WW = Work Week G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

DOCUMENT NUMBER:	98AON23319D	Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLED"	
DESCRIPTION:	3.5 MM IPAK, STRAIGHT LEAD		PAGE 1 OF 1

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